

Progress report of APMP.AUV.V-K1.1

National Institute of Advanced Industrial Science and Technology(AIST)
National Metrology Institute of Japan (NMIJ)

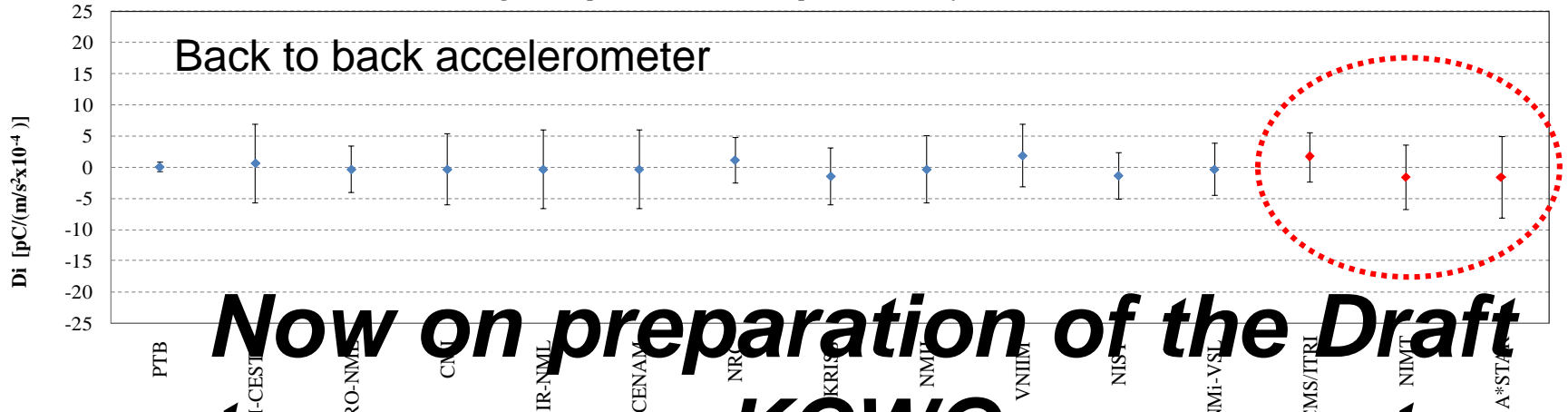
T.Usuda and A.Ota

Schedule of Circulation

Participant (laboratory name)	Acronym	Country	Country Code	Planned calibration period
National Metrology Institute of Japan	NMIJ	Japan	JP	August, 2011
Center for Measurement Standard/Industrial Technology Research Institute	CMS/ITRI	Chinese Taipei	TW	September, 2011
Interim monitoring at NMIJ				
National Metrology Centre, Agency for Science, Technology and Research	NMC, A*Star	Singapo re	SG	January, 2011
National Institute of Metrology Thailand	NIMT	Thailand	TH	March, 2012

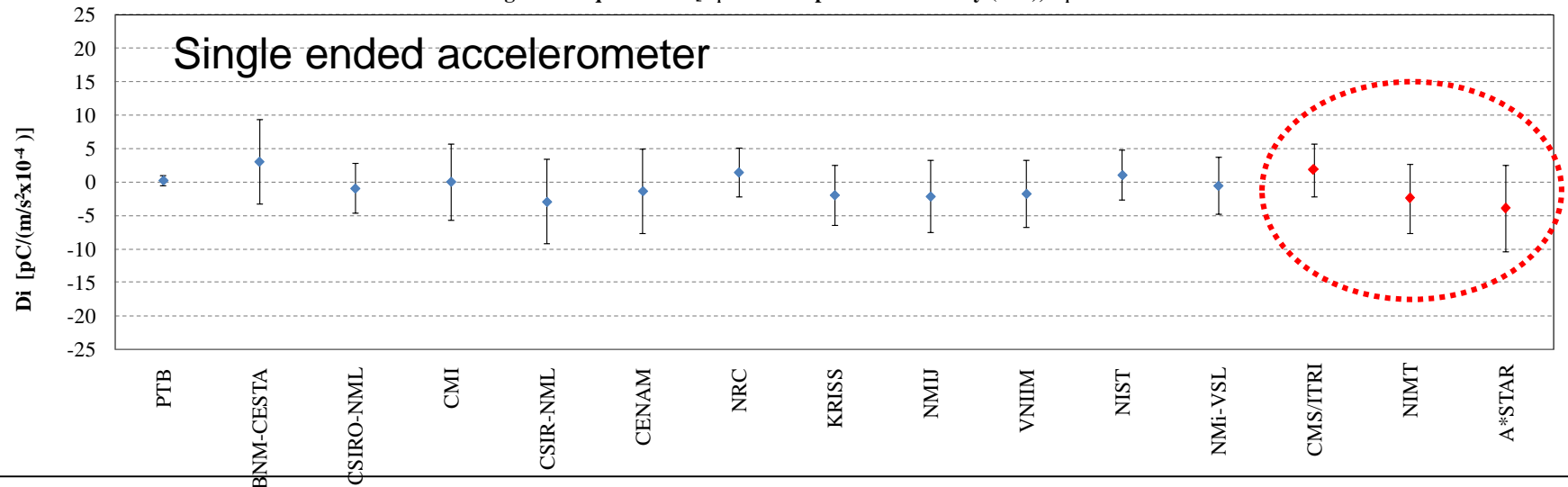
Degrees of Equivalence with the KCRV of CCCAUV.V-K1 after revision (Typically at 160 Hz)

Charge sensitivity, BB accelerometer, frequency: 160 Hz
Degrees of equivalence $[D_i]$ and its expanded uncertainty ($k=2$), U_i



Now on preparation of the Draft to response KCWG comments

Charge sensitivity, SE accelerometer, frequency: 160 Hz
Degrees of equivalence $[D_i]$ and its expanded uncertainty ($k=2$), U_i



Thank you for your attention